

Notice of References Cited	Application/Control No. 10/032,023	Applicant(s)/Patent Under Reexamination THEIL ET AL.	
	Examiner Khiem D Nguyen	Art Unit 2823	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Lim et al. (U.S. Pub. 2002/0171083 Nov. 21, 2002.
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